

Notice of References Cited	Application/Control No. 10/800,828	Applicant(s)/Patent Under Reexamination JOHNSON, TED C.	
	Examiner Saeed S. Mirzadegan	Art Unit 2144	Page 1 of 3

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Notice of References Cited	Application/Control No. 10/800,828		Applicant(s)/Patent Under Reexamination JOHNSON, TED C.	
	Examiner Saeed S. Mirzadegan		Art Unit 2144	Page 2 of 3

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	Examiner Saeed S. Mirzadegan	Art Unit 2144	Page 3 of 3

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	K	US-			
	L	US-			
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